Notice of References Cited

Application/Control No. 10/537,447 Examiner		Applicant(s)/Patent Under Reexamination IWASAKI, YOSHIO		
	Examiner	Art Unit		
	Adam C. Krupicka	1794	Page 1 of 1	

U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2008/0152850	06-2008	Paterson, Stuart Graham	428/34.8
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